

MOSFET MODULE

SF100CB100

TOP



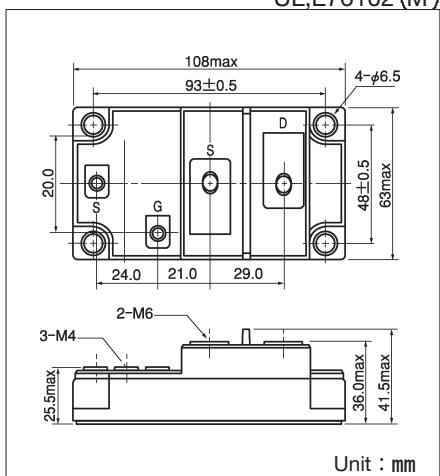
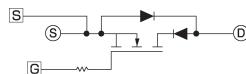
UL:E76102 (M)

SF100CB100 is a isolated power MOSFET module designed for fast switching applications of high voltage and current. The mounting base of the module is electrically isolated from semiconductor elements for simple heatsink construction.

- $I_D = 100A$, $V_{DSS} = 1000V$
- Suitable for high speed switching applications.
- Low ON resistance.
- Wide Safe Operating Areas.
- $t_{rr} \leq 300ns$

(Applications)

UPS (CVCF), Motor Control, Switching Power Supply, etc.



Unit : mm

($T_j = 25^\circ C$)

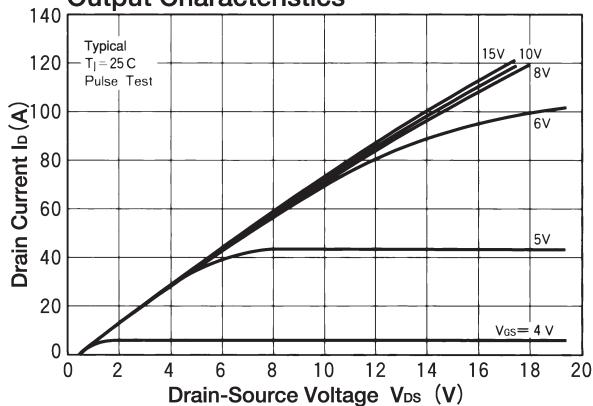
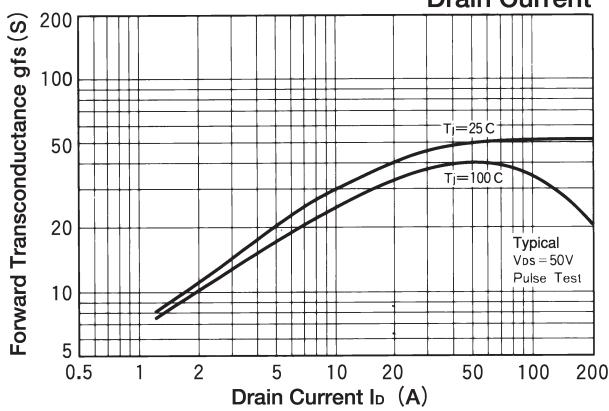
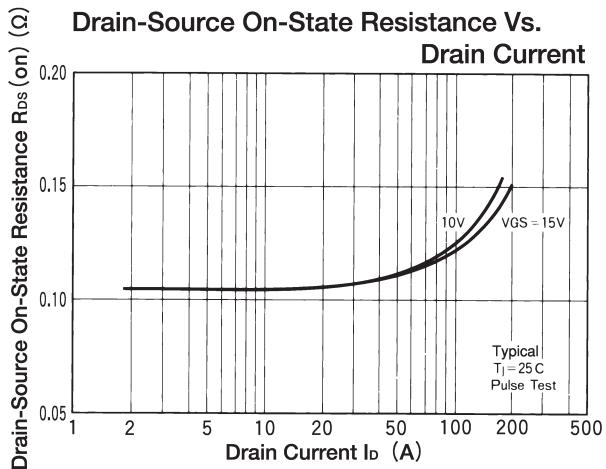
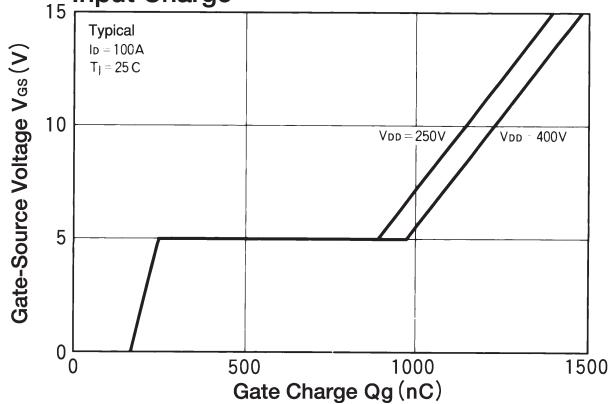
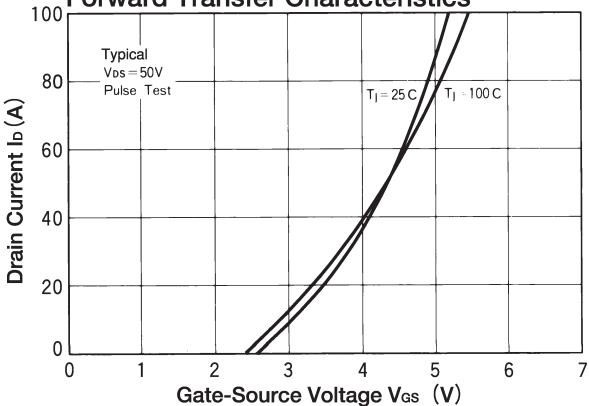
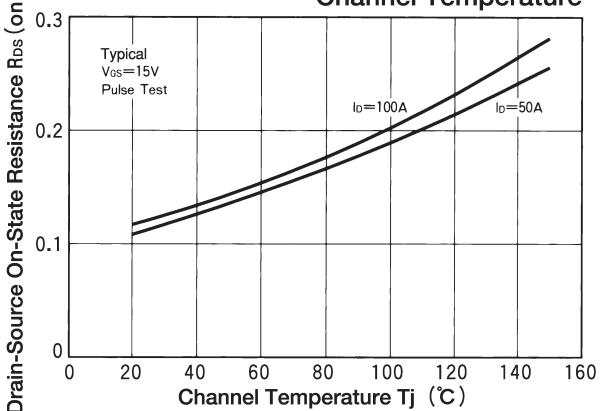
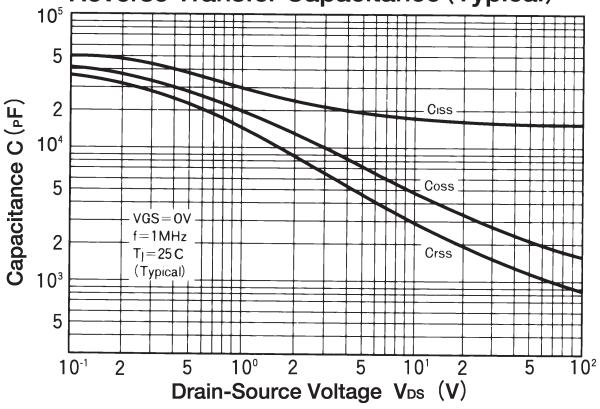
■ Maximum Ratings

Symbol	Item	Conditions	Ratings		Unit
			SF100CB100		
V_{DSS}	Drain-Source Voltage		1000		V
V_{GSS}	Gate-Source Voltage		± 30		V
I_D	Drain Current	DC	100		A
	Current	Pulse	200		
$-I_D$	Reverse Drain Current		100		A
P_T	Total Power Dissipation	$T_c = 25^\circ C$	800		W
T_j	Channel Temperature		$-40 \sim +150$		$^\circ C$
T_{stg}	Storage Temperature		$-40 \sim +125$		$^\circ C$
V_{iso}	Isolation Voltage (R.M.S.)	A.C. 1minute	2500		V
Mounting Torque	Mounting (M6)	Recommended Value			$N \cdot m$ (kgf·cm)
	Terminal (M6)	Recommended Value 2.5~3.9 (25~40)	4.7 (48)		
	Terminal (M4)	Recommended Value 1.0~1.4 (10~14)	1.5 (15)		
Mass		Typical Value	460		g

■ Electrical Characteristics

($T_j = 25^\circ C$)

Symbol	Item	Conditions	Ratings			Unit
			Min.	Typ.	Max.	
I_{GS}	Gate Leakage Current	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			± 1000	μA
I_{DS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 800V$			4.0	mA
$V_{(BR)DSS}$	Darin-Source Breakdown Voltage	$V_{GS} = 0V$, $I_D = 1mA$	1000			V
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 10mA$	1.5		3.5	V
$R_{DS(on)}$	Drain-Source On-State Resistance	$I_D = 100A$, $V_{GS} = 15V$			150	$m \Omega$
$V_{DS(on)}$	Drain-Source On-State Voltage	$I_D = 100A$, $V_{GS} = 15V$			15	V
g_{fs}	Forward Transconductance	$V_{DS} = 10A$, $V_D = 75A$	30	50		S
C_{iss}	Input Capacitance	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1.0MHz$		16000	19200	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1.0MHz$		2900	4200	pF
C_{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1.0MHz$		1800	2600	pF
td(on)	Switching Time	Turn-on Delay Time			150	ns
		Rise Time			300	
		Turn-off Delay Time	$R_L = 6 \Omega$, $V_{GS} = 15V/-5V$		600	
		Fall Time	$I_D = 100A$, $R_G = 2.2 \Omega$		300	
V_{SDS}	Diode Forward Voltage	$-I_D = 100A$, $V_{GS} = 0V$			1.8	V
t_{rr}	Reverse Recovery Time	$-I_S = 100A$, $V_{GS} = 15V$, $di/dt = 400A/\mu s$			300	ns
Rth(j-c)	Thermal Resistance	MOSFET			0.16	$^\circ C/W$
		Diode			0.64	

Output Characteristics**Forward Transconductance Vs.****Drain Current****Drain-Source On-State Resistance Vs.****Drain Current****Input Charge****Forward Transfer Characteristics****Drain-Source On-State Resistance Vs. Channel Temperature****Input Capacitance, Output Capacitance, Reverse Transfer Capacitance (Typical)****Safe Operating Area**